

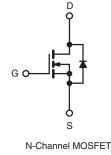
IRFS542-VB Datasheet N-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	100				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.086			
Q _g (Max.) (nC)	72				
Q _{gs} (nC)	11				
Q _{gd} (nC)	32				
Configuration	Single				

FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available





ABSOLUTE MAXIMUM RATINGS T	c = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	100	V	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at 10 V	$T_{C} = 25 \degree C$ $T_{C} = 100 \degree C$	1_	18		
	VGS AL TO V	T _C = 100 °C	ID	12	A	
Pulsed Drain Current ^a			I _{DM}	68	1	
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	720	mJ	
Repetitive Avalanche Current ^a			I _{AR}	17	A	
Repetitive Avalanche Energy ^a			E _{AR}	4.8	mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	48	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	1	
Mounting Torque	6 22 or l	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 01 1			1.1	N·m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 3.7 mH, $R_G = 25 \Omega$, $I_{AS} = 17 \text{ A}$ (see fig. 12). c. $I_{SD} \le 17 \text{ A}$, dl/dt $\le 200 \text{ A}/\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.



RoHS COMPLIANT

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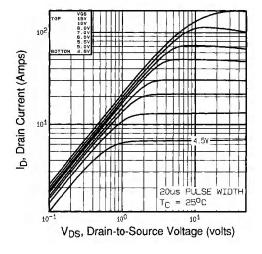
THERMAL RESISTANCE RAT	TINGS							
PARAMETER	SYMBOL	TYP	•	MAX.			UNIT	
Maximum Junction-to-Ambient	R _{thJA}	- 65			0000			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.1				°C/W		
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless otherv	vise noted			1	I		1
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 μΑ	100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	0.13	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$			-	3.0	V
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 V$			-	-	± 100	nA
Zana Oata Maltana Duain Ourreat	1	V _{DS} = 100 V, V _{GS} = 0 V	s = 0 V	-	-	25		
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 150 °C			-	-	250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 10 A ^b	-	0.086	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} :	= 50 V, I _D =	10 A ^b	9.1	-	-	S
Dynamic		•						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz			-	1700	-	
Output Capacitance	C _{oss}			-	560	-	pF	
Reverse Transfer Capacitance	C _{rss}			-	120	-		
Drain to Sink Capacitance	С			-	12	-		
Total Gate Charge	Qg		$I_{\rm D} = 17$ A, $V_{\rm DS} = 80$ V,		-	-	72	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	11	nC	
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b		-	-		32
Turn-On Delay Time	t _{d(on)}				-	11	-	
Rise Time	tr	$\begin{split} V_{DD} &= 50 \text{ V}, \text{ I}_{D} = 17 \text{ A}, \\ R_{G} &= 9.1 \ \Omega, \ R_{D} &= 2.9 \ \Omega, \\ & \text{see fig. } 10^{\text{b}} \end{split}$		-	44	-	ns	
Turn-Off Delay Time	t _{d(off)}			-	53	-		
Fall Time	t _f			-	43	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s	•						•
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	17	A	
Pulsed Diode Forward Currenta	I _{SM}	p - n junction diode			-	-		68
Body Diode Voltage	V_{SD}	T_J = 25 °C, I_S = 17 A, V_{GS} = 0 V ^b			-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 17 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	180	360	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.3	2.6	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time i	s negligible (turn	-on is dor	ninated b	/ L _S and I	_D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



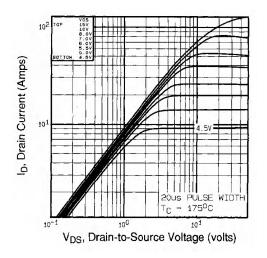


Fig. 2 - Typical Output Characteristics, $T_C = 175 \ ^\circ C$

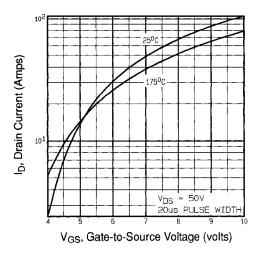


Fig. 3 - Typical Transfer Characteristics

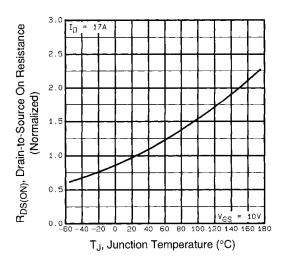


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFS542-VB



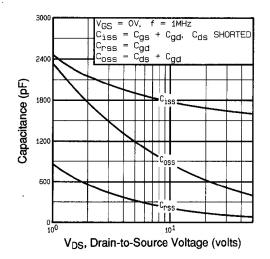


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

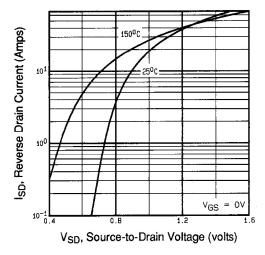


Fig. 7 - Typical Source-Drain Diode Forward Voltage

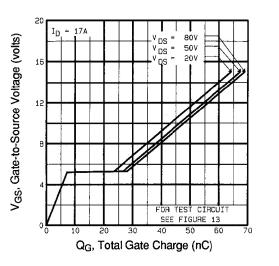


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

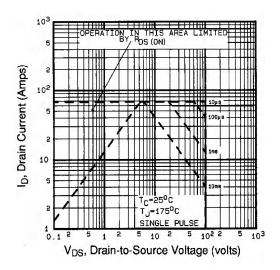


Fig. 8 - Maximum Safe Operating Area



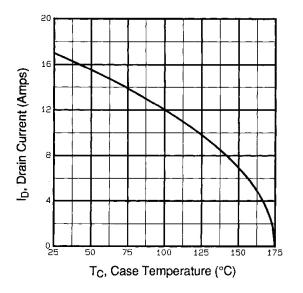


Fig. 9 - Maximum Drain Current vs. Case Temperature

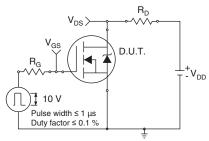


Fig. 10a - Switching Time Test Circuit

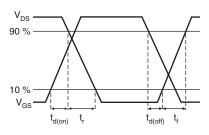
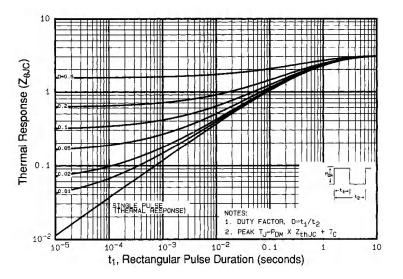


Fig. 10b - Switching Time Waveforms





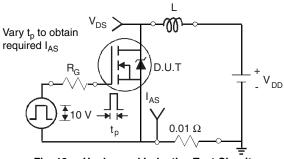


Fig. 12a - Unclamped Inductive Test Circuit

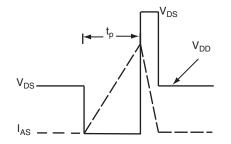


Fig. 12b - Unclamped Inductive Waveforms



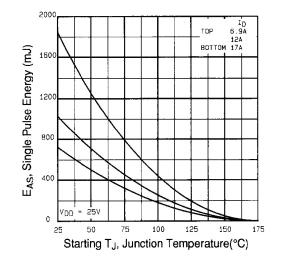


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

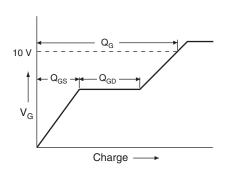
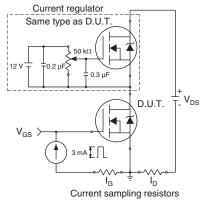
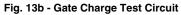
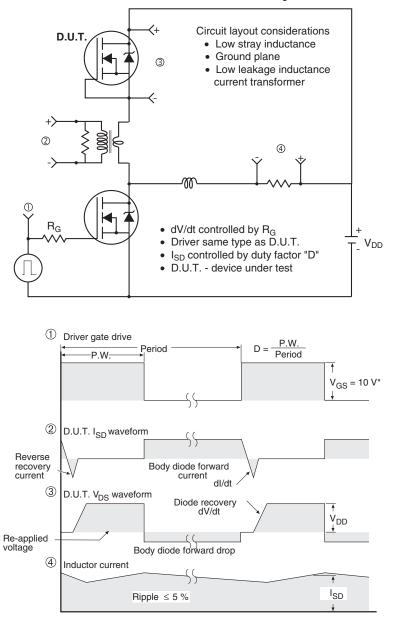


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig.14 - For N-Channel



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